## **ECEN 620**

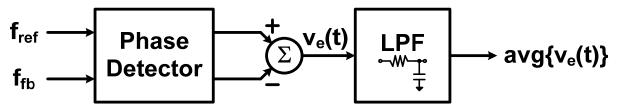
Homework #2

Due: 10-3-2024, 11:59PM Homeworks will not be received after due. Instructor: Sam Palermo

This homework requires transistor-level circuit design for Problem 2 & 3. You may use any CMOS technology to solve the problem, as long as it is a 90nm or more advanced technology node (shorter channel length). For students who do not have access to a design kit, instructions on how to access the default 90nm CMOS transistor models are posted on the website. For this 90nm technology assume a nominal 1.2V supply.

1. Phase Detector Characterization.

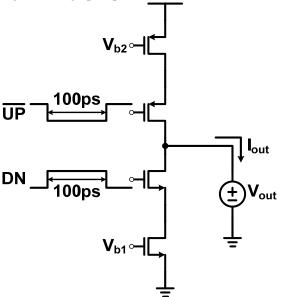
- a. For the 4 phase detectors discussed in Lecture 4 (Analog Mixer, XOR, JK Flip-Flop, PFD), produce the phase detector transfer curves ( $avg(v_e) vs \phi_e$ ). Find the phase detector gain at the nominal PLL lock point.
  - i. Use the test setup shown in the figure below with  $f_{fb}=f_{ref.}$  For the analog mixer, use sinusoidal clock inputs. For all the others, use CMOS-level square-wave clocks. Use a VCVS as a buffer between the PD output and the averaging filter. For PDs with 2 outputs, a multi-input VCVS can be used to subtract the 2 outputs before low-pass filtering.
  - ii. Plot over a phase range of  $\pm 4\pi$ , with a minimum of 20 phase points per curve.
  - iii. Feel free to use a macro-model approach to generate the phase detector transfer curves, i.e. no transistor-level design is required. Although, if you prefer to implement the circuits at the transistor level, feel free to do so.
- b. For the 4 phase detectors, find the average output with  $f_{fb}$ =0.5, 0.75, 1.5, and  $2f_{ref}$ . Assume an initial phase difference of 0°. What do these values imply regarding the usefulness of these circuits as a frequency detector?



Phase Detector Characterization Test Bench

- 2. **Phase-Frequency Detector Design.** Design at the transistor level a PFD working at 100MHz with a minimum PFD output pulse width of at least 100ps.
  - a. Give the transistor-level schematic and simulations showing the minimum PFD pulse width specification is satisfied.
  - b. Plot the phase transfer characteristic over a phase range of  $\pm 4\pi$ , with a minimum of 20 phase points per curve.

- 3. Charge Pump Design. Design at the transistor level a simple charge pump (Lecture 5, Slide 8) that can supply a nominal I<sub>CP</sub>=100μA and operate with the PFD from Problem 2. Use one ideal reference current source and appropriate current mirrors to produce the charge pump bias voltages (V<sub>b1</sub> & V<sub>b2</sub>).
  - a. Use the test setup shown in the figure below with ideal 100ps switch signals that are in-phase. Use an ideal voltage source at the charge pump output to sense the net output current, I<sub>out</sub>. From the transient I<sub>out</sub> response, plot the peak (absolute value) and the average I<sub>out</sub> as Vout is swept from 0.2\*VDD to 0.8\*VDD. Compute the phase error produced by the average I<sub>out</sub> value.
  - b. Repeat part (a) using the PFD designed in Problem 2 to produce the charge pump switch signals. Assume the PFD inputs are perfectly in-phase.
  - c. Implement appropriate design techniques to improve both the peak and average I<sub>out</sub> values, assuming the PFD is driving the charge pump.



Simple Charge Pump Characterization Test Bench